Search Notes

Application No.	Applicant(s)	
10/608,883	AVANZINO ET AL.	
Examiner	Art Unit	
Stanban W. Smoot	2812	

Class	Subclass	Date	Examiner	
257	751	5/25/2004	sws	
257	752	5/25/2004	sws	
257	759	5/25/2004	sws	\2.W.
257	760	5/25/2004	sws	
257	762	5/25/2004	sws	)
Updated	Above	11/5/2004	sws 🐇	W.S.
Updated	Above	4/26/2005	sws &	W.S.

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
	1					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Considered all citations from parent applications.	5/25/2004	I.W.L.		
Key Words: Damascene Structure - Inlaid, Copper, Electroplated, Seed Layer;	5/25/2004	IN.S sws		
Interlayer Dielectric - SiCOH, MSQ; Insulating Barrier - SiCH.	5/25/2004	IW. sws		
Updated Above Search	11/5/2004	LW.L sws		
Updated Above Search	4/26/2005	L.W.L sws		
Search Tools - EAST (attached): USPAT; US PG PUBS; Derwent; EPO; JPO; IBM TDB	5/25/2004; 11-5-04; &	sws		
·	4-76-04	AWA		